# **Power MOSFET**

# 16 V, 51 A, Single N-Channel, DPAK/IPAK

#### **Features**

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- Three Package Variations for Design Flexibility
- These are Pb-Free Devices

### **Applications**

- DC-DC Converters
- High Side Switching

## **MAXIMUM RATINGS** ( $T_J = 25^{\circ}C$ unless otherwise stated)

Para	ameter		Symbol	Value	Unit	
Drain-to-Source Vol	tage		$V_{DSS}$	16	V	
Gate-to-Source Volt	age		$V_{GS}$	±16	V	
Continuous Drain		T <sub>A</sub> = 25°C	Ι <sub>D</sub>	13.8	Α	
Current R <sub>θJA</sub> (Note 1)		T <sub>A</sub> = 85°C		10.7		
Power Dissipation R <sub>θJA</sub> (Note 1)		T <sub>A</sub> = 25°C	P <sub>D</sub>	2.6	W	
Continuous Drain		T <sub>A</sub> = 25°C	I <sub>D</sub>	9.6	Α	
Current R <sub>θJA</sub> (Note 2)	Steady State	T <sub>A</sub> = 85°C		7.4		
Power Dissipation R <sub>θJA</sub> (Note 2)	State	T <sub>A</sub> = 25°C	P <sub>D</sub>	1.2	W	
Continuous Drain		T <sub>C</sub> = 25°C	Ι <sub>D</sub>	51	Α	
Current R <sub>θJC</sub> (Note 1)		T <sub>C</sub> = 85°C		39		
Power Dissipation R <sub>θJC</sub> (Note 1)		T <sub>C</sub> = 25°C	P <sub>D</sub>	34.9	W	
Pulsed Drain Current	t <sub>p</sub> =10μs	T <sub>A</sub> = 25°C	I <sub>DM</sub>	114	Α	
Current Limited by P	ackage	T <sub>A</sub> = 25°C	I <sub>DmaxPkg</sub>	35	Α	
Operating Junction a Temperature	Operating Junction and Storage Temperature				°C	
Source Current (Bod	Source Current (Body Diode)					
Drain to Source dV/d	dV/dt	6	V/ns			
Single Pulse Drain-to-Source Avalanche Energy ( $T_J$ = 25°C, $V_{DD}$ = 50 V, $V_{GS}$ = 10 V, $I_L$ = 10 $A_{pk}$ , $L$ = 0.3 mH, $R_G$ = 25 $\Omega$ )			EAS	15	mJ	
Lead Temperature fo (1/8" from case for 10		Purposes	TL	260	°C	

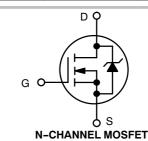
Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.



## ON Semiconductor®

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V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
16 V	8.75 mΩ @ 10 V	51 A
10 7	14.5 mΩ @ 4.5 V	51 K







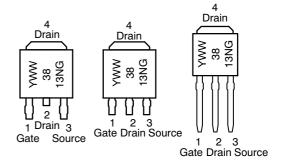


CASE 369AA **DPAK** (Bent Lead) STYLE 2

CASE 369AC 3 IPAK (Straight Lead) (Straight Lead

**CASE 369D IPAK** DPAK)

#### **MARKING DIAGRAMS & PIN ASSIGNMENTS**



= Year WW = Work Week 3813N = Device Code = Pb-Free Package

#### **ORDERING INFORMATION**

See detailed ordering and shipping information in the package dimensions section on page 6 of this data sheet.

#### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	4.3	°C/W
Junction-to-TAB (Drain)	$R_{\theta JC-TAB}$	3.6	
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	58	
Junction-to-Ambient – Steady State (Note 2)	$R_{\theta JA}$	121	

- Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
   Surface-mounted on FR4 board using the minimum recommended pad size.

## **ELECTRICAL CHARACTERISTICS** (T<sub>1</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Cond	lition	Min	Тур	Max	Unit
OFF CHARACTERISTICS			_				
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V, } I_D = 250 \mu\text{A}$		16			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /				16.8		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{GS} = 0 V$ , $T_{J} = 25^{\circ}C$				1.0	
		V <sub>DS</sub> = 16 V	T <sub>J</sub> = 125°C			10	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>G</sub>	<sub>S</sub> = ±16 V			±100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_{D}$	= 250 μA	1.5		2.5	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				5.3		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 15 A		7.2	8.75	0
		V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 15 A		11	14.5	mΩ
Forward Transconductance	9FS	V <sub>DS</sub> = 1.5 V, I <sub>D</sub> = 15 A			40		S
CHARGES AND CAPACITANCES							
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1.0 MHz, V <sub>DS</sub> = 12 V			963		pF
Output Capacitance	C <sub>OSS</sub>				338		
Reverse Transfer Capacitance	C <sub>RSS</sub>				191		1
Total Gate Charge	Q <sub>G(TOT)</sub>				8.5	12.8	
Threshold Gate Charge	Q <sub>G(TH)</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> =	10 \/   15 \		0.93		nC
Gate-to-Source Charge	Q <sub>GS</sub>	v <sub>GS</sub> = 4.5 v, v <sub>DS</sub> =	12 V, ID = 15 A		3.1		
Gate-to-Drain Charge	$Q_{GD}$				3.8		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> =	12 V, I <sub>D</sub> = 15 A		16.7		nC
SWITCHING CHARACTERISTICS (Note	4)						
Turn-On Delay Time	t <sub>d(ON)</sub>				12		
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 4.5 V, V	<sub>DS</sub> = 12 V,		38		1
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$V_{GS} = 4.5 \text{ V}, V_{DS} = 12 \text{ V},$ $I_{D} = 15 \text{ A}, R_{G} = 3.0 \Omega$			14		ns
Fall Time	t <sub>f</sub>				5.0		
Turn-On Delay Time	t <sub>d(ON)</sub>				8.0		
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 10 V, V <sub>E</sub>	ns = 12 V,		33		1
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$I_D = 15 A, R_G$	$= 3.0 \Omega$		20		ns
Fall Time	t <sub>f</sub>				8.0		7

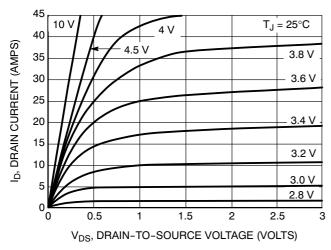
- 3. Pulse Test: pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2%.
- 4. Switching characteristics are independent of operating junction temperatures.5. Assume standoff of 110 mm.

## **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Cond	ition	Min	Тур	Max	Unit
DRAIN-SOURCE DIODE CHARACTER	RISTICS			•	•	•	•
Forward Diode Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C		0.88	1.2	V
		$V_{GS} = 0 V,$ $I_{S} = 15 A$	T <sub>J</sub> = 125°C		0.76		V
Reverse Recovery Time	t <sub>RR</sub>	· ·			14.4		ns
Charge Time	t <sub>a</sub>	$V_{GS} = 0 \text{ V, dIS/dt}$	Vos = 0 V. dlS/dt = 100 A/us.		6.8		
Discharge Time	t <sub>b</sub>	$V_{GS} = 0 \text{ V, dIS/dt} = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 15 \text{ A}$			7.6		
Reverse Recovery Charge	$Q_{RR}$				3.7		nC
PACKAGE PARASITIC VALUES							
Source Inductance	L <sub>S</sub>				2.49		nH
Drain Inductance, DPAK	L <sub>D</sub>	1			0.0164		
Drain Inductance, IPAK (Note 5)	L <sub>D</sub>	T <sub>A</sub> = 25°C			1.88		
Gate Inductance	L <sub>G</sub>				3.46		
Gate Resistance	$R_{G}$				0.4		Ω

<sup>3.</sup> Pulse Test: pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2%. 4. Switching characteristics are independent of operating junction temperatures. 5. Assume standoff of 110 mm.

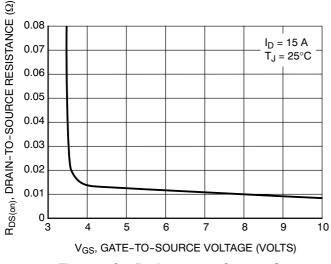
#### TYPICAL PERFORMANCE CURVES



45  $V_{DS} \ge 10 \text{ V}$ 40 DRAIN CURRENT (AMPS) 35 30 25 20 15 T<sub>J</sub> = 125°C 10  $T_J = 25^{\circ}C$ ث  $T_J = -55^{\circ}C$ 01 5 V<sub>GS</sub>, GATE-TO-SOURCE VOLTAGE (VOLTS)

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



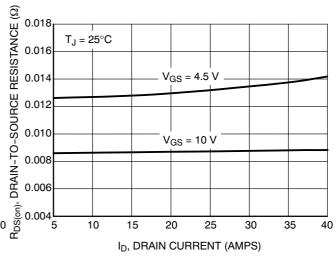
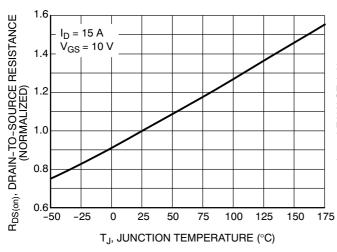


Figure 3. On-Resistance vs. Gate-to-Source Voltage

Figure 4. On-Resistance vs. Drain Current and Gate Voltage



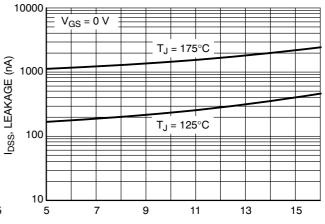


Figure 5. On–Resistance Variation with Temperature

V<sub>DS</sub>, DRAIN-TO-SOURCE VOLTAGE (VOLTS)

Figure 6. Drain-to-Source Leakage Current
vs. Drain Voltage

#### TYPICAL PERFORMANCE CURVES

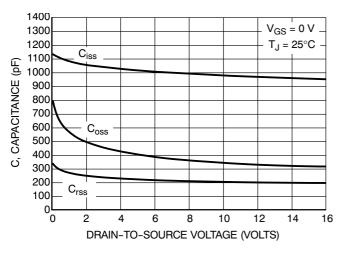


Figure 7. Capacitance Variation

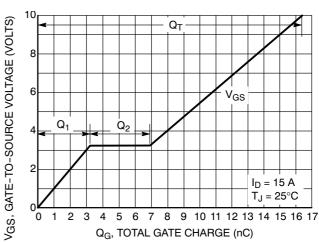


Figure 8. Gate-To-Source and Drain-To-Source Voltage vs. Total Charge

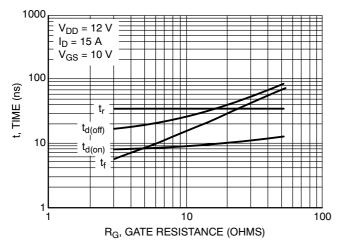


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

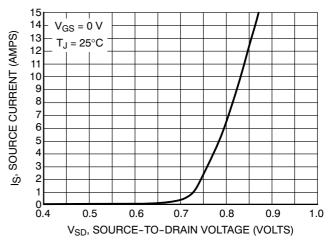


Figure 10. Diode Forward Voltage vs. Current

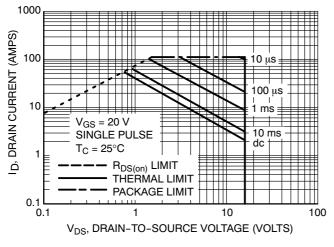


Figure 11. Maximum Rated Forward Biased Safe Operating Area

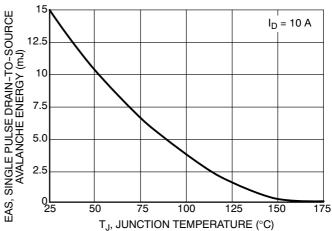


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

### **ORDERING INFORMATION**

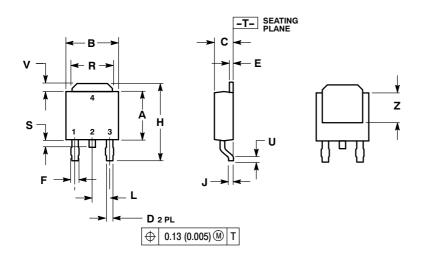
Device	Package	Shipping <sup>†</sup>
NTD3813NT4G	DPAK (Pb-Free)	2500 / Tape & Reel
NTD3813N-1G	IPAK (Pb-Free)	75 Units / Rail
NTD3813N-35G	IPAK Trimmed Lead (3.5 $\pm$ 0.15 mm) (Pb-Free)	75 Units / Rail

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

### **PACKAGE DIMENSIONS**

## **DPAK (SINGLE GAUGE)**

CASE 369AA-01 **ISSUE A** 

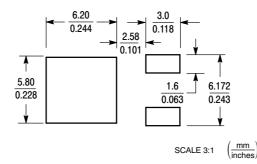


- NOTES:
  1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
  2. CONTROLLING DIMENSION: INCH.

	INC	HES	MILLIM	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.22
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.025	0.035	0.63	0.89
Е	0.018	0.024	0.46	0.61
F	0.030	0.045	0.77	1.14
Н	0.386	0.410	9.80	10.40
J	0.018	0.023	0.46	0.58
L	0.090	BSC	2.29	BSC
R	0.180	0.215	4.57	5.45
S	0.024	0.040	0.60	1.01
U	0.020		0.51	
٧	0.035	0.050	0.89	1.27
Z	0.155		3.93	

STYLE 2: PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN

### **SOLDERING FOOTPRINT\***

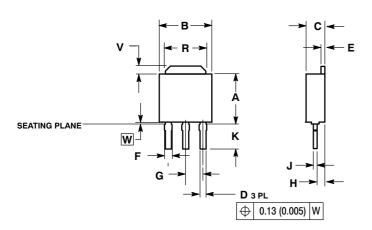


\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

#### PACKAGE DIMENSIONS

### 3 IPAK, STRAIGHT LEAD

CASE 369AC-01 ISSUE O



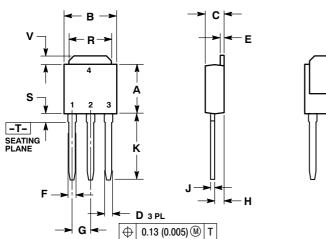
#### NOTES:

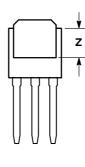
- 1.. DIMENSIONING AND TOLERANCING
- PER ANSI Y14.5M, 1982. CONTROLLING DIMENSION: INCH.
- SEATING PLANE IS ON TOP OF DAMBAR POSITION.
- DIMENSION A DOES NOT INCLUDE DAMBAR POSITION OR MOLD GATE.

	INCHES		MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.22
В	0.250	0.265	6.35	6.73
C	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
Е	0.018	0.023	0.46	0.58
F	0.037	0.043	0.94	1.09
G	0.090	BSC	2.29	BSC
Н	0.034	0.040	0.87	1.01
7	0.018	0.023	0.46	0.58
K	0.134	0.142	3.40	3.60
R	0.180	0.215	4.57	5.46
٧	0.035	0.050	0.89	1.27
w	0.000	0.010	0.000	0.25

#### **IPAK (STRAIGHT LEAD DPAK)**

CASE 369D-01 **ISSUE B** 





- NOTES:
  1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. CONTROLLING DIMENSION: INCH.

	INC	HES	MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.35
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
Е	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.090	0.090 BSC		BSC
Н	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
K	0.350	0.380	8.89	9.65
R	0.180	0.215	4.45	5.45
S	0.025	0.040	0.63	1.01
٧	0.035	0.050	0.89	1.27
Z	0.155		3.93	

STYLE 2:

PIN 1. GATE

- DRAIN
   SOURCE
- DRAIN

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